

Search Notes

Application/Control No.

10/724,471

Examiner

James D. Stein

Applicant(s)/Patent under
Reexamination

ZHONG ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	15,47,88 92,130	2/28/2006	JDS
398	82,83	2/28/2006	JDS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	2/28/2006	JDS
IEEE and INPSEC: coupler, thin film, add, drop, multiplex, demultiplex, substrate	2/28/2006	JDS